

Search Notes



Application No.

10/779,559

Examiner

Sang Y Paik

Applicant(s)

FURUKAWA ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	443.1 444.1 445.1 446.11		
	465.1 466.1		
118	724 725	10/15/04	JP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
ENT TGT, INCLCIED	10/15/04	JP